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SN820X Family Data Sheet

Wi-Fi Network Controller Module

Revision History

Revision	Date	Author	Change Description
0.1	12/09/2012	Y. Fang	Initial version
0.5	02/03/2012	Y. Fang	Preliminary version
0.6	02/20/2012	N. Nagayama	Update performance data and adjusted table format
0.7	04/20/2012	J. Gregus	Update CE compliance information
1.0	08/27/2012	Y. Fang	Formal release
1.1	01/23/2013	Y. Fang	Added Power Rail Current specification and Standby Mode Current specification
1.2	05/30/2013	R. Willett	Changed specs in Table 1 for Pin 2, 3, 4, and 30
1.3	09/20/2013	R Willett	Separated Data Sheet/User Manual and created new data sheet combining SN8200/8200 UFL and SN8205/8205 UFL
1.4	11/07/13	R. Willett	Added Acronyms list; Revised Fig. 1.1, 2.1; revised content and renumbered tables in Chap. 3: added Chapters 4 - 10 and reorganized information; amended regulatory information.
1.5	11/11/13	R Willett	Revised Operating Temperature specification on page 6; revised Table 5.1 “Absolute Maximum Ratings,” page 38.
2.0	11/25/13	R Willett	Removed references to SyChip; updated copyright, deleted Chap 11, “Disclaimer;”
2.1	12/17/13	R. Willett	Added text describing module software download in Chapter 1, page 7.
2.2	02/28/14	R. Willett	Revised text on page 42, Table 9.2.
3.0	07/25/14	R. Willett	Reformatted document to new Murata visual identity; Added Anatel certification, page 39
3.1	8/22/14	R. Willett	Revised Table 5.1 to include VDD, VBAT and VDD_WiFi.
3.2	3/21/16	R. Willett	Deleted minimum values for Receive Sensitivity on Table 4.1.1 page 34, Table 4.2.1 page 35, and Table 4.3.1 page 36; updated Murata address on page 42.

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1 Introduction

1.1 Model SN820X Module Family

The SN820X Module Family is a portfolio of low power, self-contained, embedded wireless module solutions that address the connectivity demands of M2M applications. These products integrate a micro-controller, a Wi-Fi BB/MAC/RF IC, an RF front end and two clocks into small form factor modules. The module family includes 2 different micro-controller options as shown below. The modules can also be purchased with either a standard on-board chip antenna or a U.FL connector where remote antenna flexibility is required.

TABLE 1.1: SN820X WiFi Network Controller Module Family

Model #	P/N	Built-in STM	RAM Size	Flash Size
SN8200	88-00151-00	ARM Cortex M3	96KB	768KB
SN8200UFL	88-00151-02	ARM Cortex M3	96KB	768KB
SN8205	88-00158-00	ARM Cortex M3	128KB	1024KB
SN8205UFL	88-00158-02	ARM Cortex M3	128KB	1024KB

1.2 Model SN820X Module Features

- 2.4 GHz IEEE 802.11 b/g/n radio technology
- Dimensions: 30.5 × 19.4 × 2.8 mm
- Antenna configurations: On-board antenna or U.FL connector
- Transmitter power: +18 dBm @80211b
- Receiver sensitivity: -96 dBm
- MCU: ARM Cortex-M3
- Serial Interface Options: UART, SPI
- Peripheral Interface Options: ADC, DAC, I2C, I2S, GPIO
- Operating temperature range: -40 ºC to +85 ºC
- RoHS2 compliant
- MSL Level 3
- FCC/IC certified and CE compliant
- Compatible with Broadcom WICED™ SDK

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1.3 Block Diagram

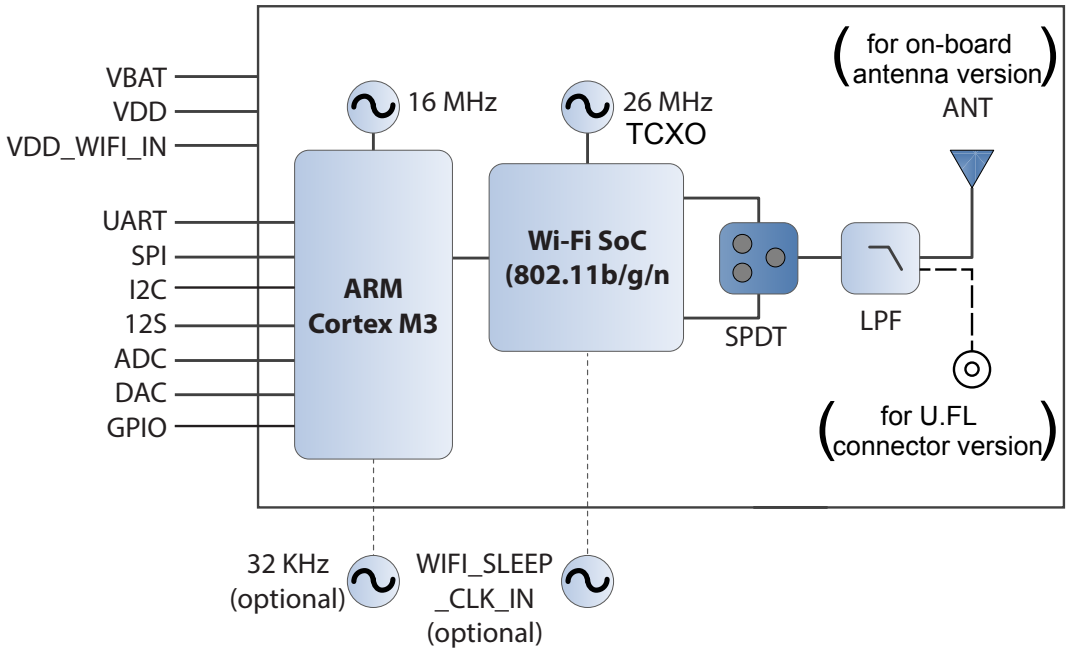


FIGURE 1.1: SN820X Block Diagram

Murata offers Serial-to-WiFi and EZ Web Wizzard software for SN820x in the SN820x EVK+. The modules are also compatible with Broadcom WICED™ SDK. The customer can obtain the WICED™ SDK from Broadcom directly. **The modules are delivered with no application firmware pre-installed.**

Finalize the firmware image, and then download the firmware to the module. For more details, please see reference [4].

1.4 Acronyms

- **ADC** Analog to Digital Converter
- **DAC** Digital to Analog Converter
- **GPIO** General-Purpose Input-Output
- **I2C** Intelligent Interface Controller
- **I2S** Integrated Interchip Sound
- **ISM** Industrial, Scientific and Medical
- **MAC** Medium Access Control
- **MSL** Moisture Sensitivity Level
- **PER** Packet Error Rate
- **ROHS** Restriction of Hazardous Substances
- **SPI** Serial Peripheral Interface
- **UART** Universal Asynchronous Receiver-Transmitter

1.5 References

[1] STM32F103RF Data Sheet, ST Microelectronics
[2] STM32F205RG, Data Sheet, ST Microelectronics
[3] SN820X Wi-Fi Network Controller Module Family User Manual, Murata
[4] AN_SN8200_002 SN820X Firmware Downloading Application Note, Murata

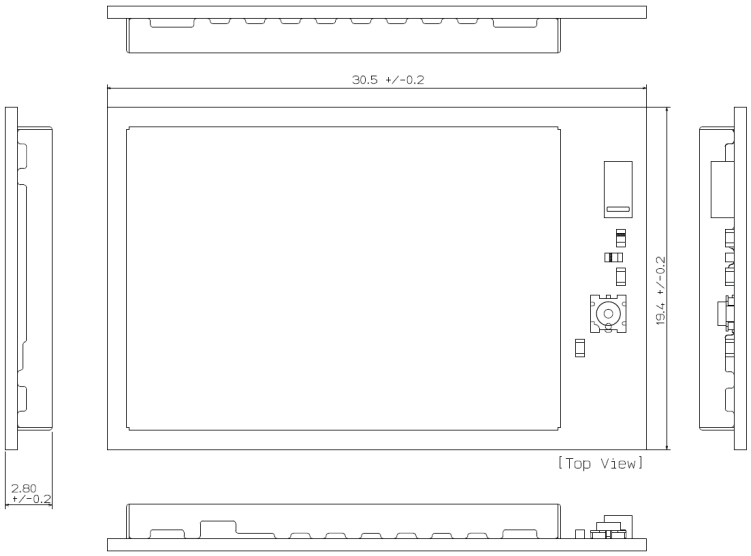
2 Mechanical Specifications

2.1 Module Dimensions

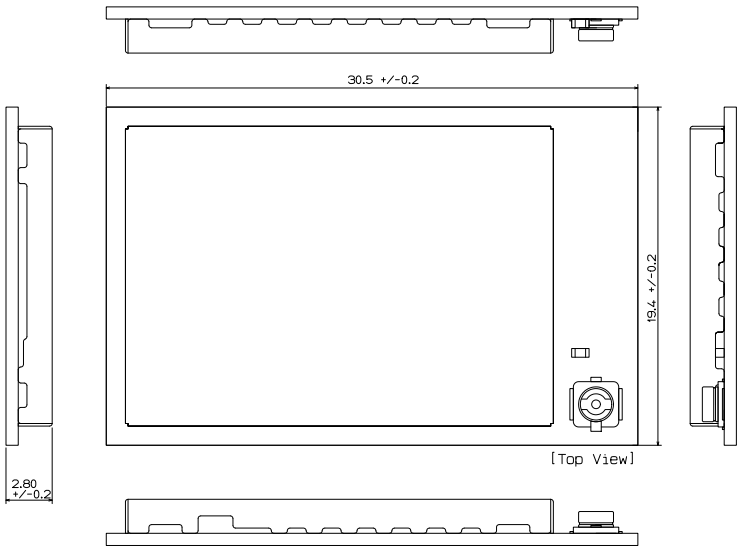
TABLE 2.1: Module Dimensions

Parameter	Typical	Units
Dimensions (LxWxH)	30.5 x 19.4 x 2.8	mm
Dimension tolerances (LxWxH)	±0.2	mm

2.2 Top and Side View



SN820X Top and Side View



SN820XUFL Top and Side View

FIGURE 2.1: SN820X and SN820XUFL Top and Side View

2.3 PCB Footprint (top view)

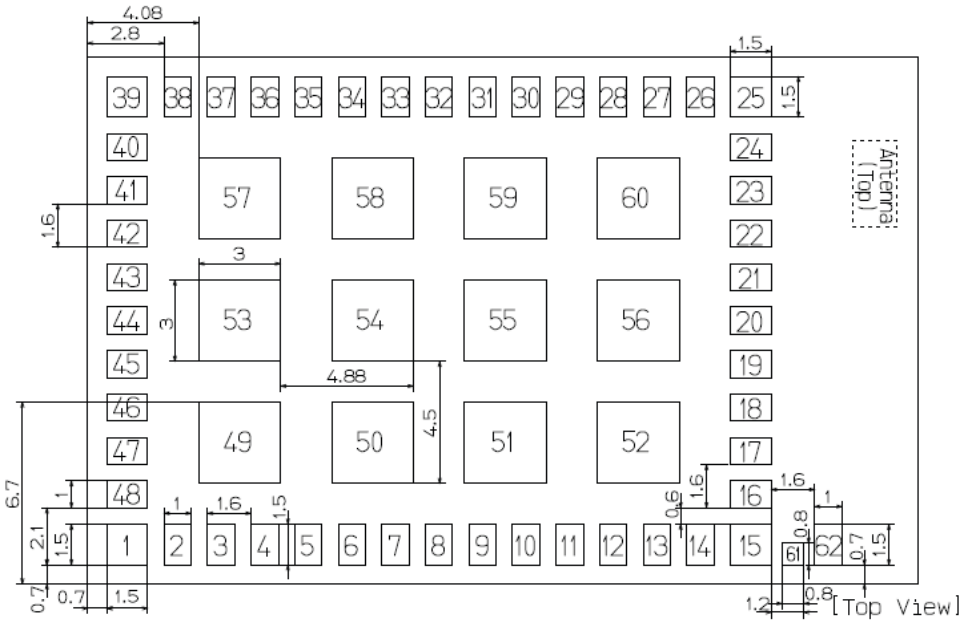


FIGURE 2.2: Detailed Pad Dimensions (top view)

2.4 Pinouts

TABLE 2.2: Pinouts

Pin #	Pin Name	I/O	Description
1	GND	-	Ground
2	OSC32_IN	I/O	Optional precision 32.768 KHz slow clock input. No connect if not used
3	OSC32_OUT	I/O	No connect
4	WIFI_VDD_EN	I/O	No connect
5	ADC3	I/O	General purpose I/O or ADC3
6	ADC4	I/O	General purpose I/O or ADC4
7	ADC5	I/O	General purpose I/O or ADC5
8	VDD	PI	DC supply for MCU and I/O
9	ADC6	I/O	General purpose I/O or ADC6
10	DAC2	I/O	General purpose I/O or DAC2
11	DAC1	I/O	General purpose I/O or DAC1
12	ADC1	I/O	General purpose I/O or ADC1
13	Reserved	-	No connect
14	Reserved	-	No connect
15	GND	-	Ground
16	GND	-	Ground
17	GND	-	Ground
18	GND	-	Ground
19	GND	-	Ground
20	GND	-	Ground
21	GND	-	Ground
22	GND	-	Ground
23	GND	-	Ground
24	GND	-	Ground
25	GND	-	Ground
26	VDD_WIFI_IN	PI	Wi-Fi power supply
27	Reserved	-	No connect
28	Reserved	-	No connect
29	Reserved	-	No connect
30	WIFI_SLEEP_CLK_IN	I	Optional precision 32.768 kHz Wi-Fi sleep clock input. Tie to GND if not used
31	GND	-	Ground
32	UART_TX	I/O	General purpose I/O or UART_TX
33	UART_RX	I/O	General purpose I/O or UART_RX
34	UART_CTS	I/O	General purpose I/O or UART_CTS
35	UART_RTS	I/O	General purpose I/O or UART_RTS
36	JTMS	I/O	General purpose I/O or JTMS

TABLE 2.2: Pinouts (Continued)

37	JTDI/SPI_NSS	I/O	General purpose I/O or JTDI or SPI_NSS
Pin #	**Pin Name**	**I/O**	**Description**
38	JTCK	I/O	General purpose I/O or JTCK
39	Ground	-	Ground
40	JTDO/SPI_SCK	I/O	General purpose I/O or JTDO or SPI_SCK
41	JTRST/SPI_MISO	I/O	General purpose I/O or JTRST or SPI_MISO
42	SPI_MOSI	I/O	General purpose I/O or SPI_MOSI
43	I2C_SCL	I/O	General purpose I/O or I2C_SCL
44	I2C_SDA	I/O	General purpose I/O or I2C_SDA
45	BOOT	-	Normal operation if connected to ground at power up.
46	ADC2	I/O	General purpose I/O or ADC2
47	MICRO_RST_N	I	Module reset
48	VBAT	PI	Power supply for backup circuitry when VDD is not present
49	GND	-	Ground
50	GND	-	Ground
51	GND	-	Ground
52	GND	-	Ground
53	GND	-	Ground
54	GND	-	Ground
55	GND	-	Ground
56	GND	-	Ground
57	GND	-	Ground
58	GND	-	Ground
59	GND	-	Ground
60	GND	-	Ground
61	Reserved	-	No connect
62	GND	-	Ground

TABLE 2.3: Signal Pinouts for SN820X/820XUFL

Pin	Pin name	STM32F103RF/STM32F205RG pin
5	ADC3	PA0/WKUP/ADC123_0/USART2_CTS TIM2_CH1_ETR/ TIM5_CH1 / TIM8_ETR
6	ADC4	PA1/ADC123_1/USART2_RTS TIM2_CH2 / TIM5_CH2
7	ADC5	PA2/ADC123_2/USART2_TX TIM2_CH3 / TIM5_CH3 / TIM9_CH1
9	ADC6	PA3/ADC123_3/USART2_RX TIM2_CH4 / TIM5_CH4 / TIM9_CH2
10	DAC2	PA4/ADC12_4/DAC1/USART2_CK/SPI1_NSS
11	DAC1	PA5/ADC12_5/DAC2/SPI1_SCK
12	ADC1	PA7/ADC12_7/SPI1_MOSI
32	UART_TX	PA9/UART1_TX
33	UART_RX	PA10/UART1_RX
34	UART_CTS	PA11/UART1_CTS/USB2_DM/CAN_RX
35	UART_RTS	PA12/UART1_RTS/USB2_DP/CAN_TX
36	JTMS	PA13/JTMS/SWIO
37	JTDI/SPI_NSS	PA15/JTDI/SPI3_NSS/I2S3_WS
38	JTCK	PA14/JTCK/SWCLK
40	JTDO/SPI_SCK	PB3/JTDO/SPI3_SCK/I2S3_CK
41	JTRST/SPI_MISO	PB4/JTRST/SPI3_MISO
42	SPI_MOSI	PB5/I2C1_SMBA/SPI3_MOSI/ I2S3_SD
43	I2C_SCL	PB6/I2C1_SCL TIM4_CH1
44	I2C_SDA	PB7/I2C1_SDA TIM4_CH2
46	ADC2	PA6/ADC12_6/SPI1_MISO

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3 DC Electrical Specifications

The I/O pins from SN820X are based on the built-in STM32 microcontroller. The information shown in sections 3.2 through 3.8 is derived from the ST Microelectronics Data Sheet for user convenience. For original information, see reference [1] and [2] on page of References.

3.1 Typical Power Consumption

TABLE 3.1.1: SN8200/SN8200UFL and SN8205/SN8205 UFL Typical Power Consumption

Item		Condition	Values			Units
			Min	Typ	Max	
11b	Receive mode	11 Mbps		110		mA
	Transmit mode (18 dBm/ 100% Duty Cycle)			370		mA
11g	Receive mode	54 Mbps		110		mA
	Transmitmode (14.5 dBm/100% Duty Cycle)			290		mA
11n	Receive mode	MCS7		110		mA
	Transmit mode (13.5 dBm/ 100% Duty Cycle)			280		mA
Standby Mode with IEEE802.11 Power Save		DTIM 1, Telnet session established and idling		3.15		mA
Standby Mode with IEEE802.11 Power Save		DTIM 3, Telnet session established and idling		1.28		mA

3.2 GPIO Interface

The general purpose I/O (GPIO) pins available on the SN820X will connect to various external devices. GPIOs are configured as input floating by default. Subsequently, they can be programmed to be either input or output pins via the GPIO control register. They can also be programmed to have internal pull-up or pull-down resistors. The MICRO_RST_N pin is connected to a permanent pull-up resistor, R_{PU}.

TABLE 3.2.1: Digital I/O Characteristics SN8200/SN8200UFL

	SYM	min.	typ.	max.	unit
Input Low Voltage[1]	V_{IL}	-0.3		0.28 (V_{DD}-2) +0.8	V
Input High Voltage[1]	V_{IH}	0.41 (V_{DD}-2) +1.3		V_{DD}+0.3	V
Input Low Voltage[2]	V_{IL}	-0.3		0.32 (V_{DD}2) +0.75	V
Input High Voltage[2]	V_{IH}	0.42 (V_{DD}-2) +1		V_{DD} +0.5	V
Input Low Voltage (MICRO_RST_N)	V_{IL}	-0.5		0.8	V
Input High Voltage (MICRO_RST_N)	V_{IH}	2		V_{DD} + 0.5	V
Output Low Voltage	V_{OL}			0.4	V
Output High Voltage	V_{OH}	V_{DD} - 0.4			V
Weak Pull-up Equivalent Resistor	R_{PU}	30	40	50	kΩ
Weak Pull-down Equivalent resistor	R_{PD}	30	40	50	kΩ

1 - for pins 5, 6, 7, 9, 10, 11, 12, 42, 46

2 - for pins 32 - 38, 40, 41, 43, 44

TABLE 3.2.2: Digital I/O Characteristics, SN8205/8205UFL

	SYM	min.	typ.	max.	unit
Input Low Voltage[1]	V_{IL}	-0.3		0.3 V_{DD}	V
Input High Voltage[1]	V_{IH}	0.7 V_{DD}		3.6	V
Input Low Voltage[2]	V_{IL}	-0.3		0.3 V_{DD}	V
Input High Voltage[2]	V_{IH}	0.7		3.6	V
Input Low Voltage (MICRO_RST_N)	V_{IL}	-0.5		0.8	V
Input High Voltage (MICRO_RST_N)	V_{IH}	2		V_{DD} + 0.5	V
Output Low Voltage	V_{OL}			0.4	V
Output High Voltage	V_{OH}	V_{DD} - 0.4			V
Weak Pull-up Equivalent Resistor	R_{PU}	30/8*	40/11*	50/15*	kΩ
Weak Pull-down Equivalent resistor	R_{PD}	30/8*	40/11*	50/15*	kΩ

1 - for pins 5, 6, 7, 9, 10, 11, 12, 42, 46

2 - for pins 32-38, 40, 41, 43, 44

(*) - Pin 33

3.3 Output driving current

The GPIOs (general purpose input/outputs) can sink or source up to ±8 mA, and sink or source up to ±20 mA (with a relaxed VOL/VOH) except PC13, PC14 and PC15 which can sink or source up to ±3mA. When using the PC13 to PC15 GPIOs in output mode, the speed should not exceed 2 MHz with a maximum load of 30 pF.

- In the user application, the number of I/O pins which can drive current must be limited to respect the absolute maximum rating specified in Table 3.3.1.
- The sum of the currents sourced by all the I/Os on VDD, plus the maximum Run consumption of the MCU sourced on VDD, cannot exceed the absolute maximum rating IVDD.

TABLE 3.3.1: Voltage Characteristics, SN820X

Symbol	Ratings	Min	Max	U
V_{DD}–V_{SS}	External main supply voltage (including V_{DDA}, V_{DD})(1)	–0.3	4.0	V
V_{IN}	Input voltage on five-volt tolerant pin(2)	V_{SS}–0.3	V_{DD}+4	
	Input voltage on any other pin	V_{SS}–0.3	4.0	
$\lvert\Delta V_{DDx}\rvert$	Variations between different V_{DD} power pins	-	50	mV
$\lvert V_{SSx} - V_{SS}\rvert$	Variations between all the different ground pins	-	50	
$V_{ESD(HBM)}$	Electrostatic discharge voltage (human body model)		2000	V

1. All main power (V_{DD}, V_{DDA}) and ground (V_{SS}, V_{SSA}) pins must always be connected to the external power supply, in the permitted range.
2. V_{IN} maximum value must always be respected.

TABLE 3.3.2: Current Characteristics, SN8200/8200UFL

Symbol	Ratings	Max.	Uni
I_{VDD}	Total current into V_{DD}/V_{DDA} power lines (source)(1)	150	mA
I_{VSS}	Total current out of V_{SS} ground lines (sink)(1)	150	
I_{IO}	Output current sunk by any I/O and control pin	25	
	Output current source by any I/Os and control pin	25	
$I_{INJ(PIN)}$(2)	Injected current on five volt tolerant pins(3)	-5/+0	
	Injected current on any other pin(4)	± 5	
$\Sigma I_{INJ(PIN)}$	Total injected current (sum of all I/O and control pins)(5)	± 25	

TABLE 3.3.3: Current Characteristics, SN8205/8205UFL

Symbol	Ratings	Max.	Unit
I_{VDD}	Total current into V_{DD} power lines (source)(1)	120	mA
I_{VSS}	Total current out of V_{SS} ground lines (sink)(1)	120	
I_{IO}	Output current sunk by any I/O and control pin	25	
	Output current source by any I/Os and control pin	25	
$I_{INJ(PIN)}$ (2)	Injected current on five-volt tolerant I/O(3)	-5/+0	
	Injected current on any other pin(4)	±5	
$\Sigma I_{INJ(PIN)}$(4)	Total injected current (sum of all I/O and control pins)(5)	±25	

1. All main power (V_{DD}, $V_{DDA)}$ and ground (V_{SS}, $V_{SSA)}$ pins must always be connected to the external power supply, in the permitted range.
2. Negative injection disturbs the analog performance of the device.
3. Positive injection is not possible on these I/Os. A negative injection is induced by $V_{IN}<V_{SS}$. $I_{INJ(PIN)}$ must never be exceeded.
4. A positive injection is induced by $V_{IN}>V_{DD}$ while a negative injection is induced by $V_{IN}<V_{SS.}$ $I_{INJ(PIN)}$ must never be exceeded.
5. When several inputs are submitted to a current injection, the maximum $\Sigma I_{INJ(PIN)}$ is the absolute sum of the positive and negative injected currents (instantaneous values)

3.4 Output Voltage Levels

Unless otherwise specified, the parameters given in Table 3.4.1 and Table 3.4.2 are derived from tests performed under ambient temperature and V_{DD} supply voltage conditions. All I/Os are CMOS and TTL compliant.

TABLE 3.4.1: Output Voltage Characteristics, SN8200/SN8200UFL

Symbol	Parameter	Conditions	Min	Max	Unit
V_{OL}(1)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	TTL port(3) I_{IO} = +8 mA 2.7 V < V_{DD} < 3.6 V	-	0.4	V
V_{OH}(2)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		V_{DD}—0.4		
V_{OL}(1)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	CMOS port(3) I_{IO}=+ 8mA 2.7 V < V_{DD} < 3.6 V	-	0.4	V
V_{OH}(2)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		2.4		

TABLE 3.4.1: Output Voltage Characteristics, SN8200/SN8200UFL (Continued)

Symbol	Parameter	Conditions	Min	Max	Unit
V_{OL} (1)(4)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	I_{IO} = +20 mA 2.7 V < V_{DD} < 3.6 V	-	1.3	V
V_{OL} (2)(4)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		V_{DD}—1.3		
V_{OL} (1)(4)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	I_{IO}= +6 mA 2 V < V_{DD} < 2.7 V		0.4	V
V_{OL} (2)(4)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		V_{DD}—0.4		

1. The IIO current sunk by the device must always respect the absolute maximum rating specified in Table 3.4.1 and the sum of IIO (I/O ports and control pins) must not exceed IVSS.
2. The IIO current sourced by the device must always respect the absolute maximum rating specified in Table 3.4.1 and the sum of IIO (I/O ports and control pins) must not exceed IVDD.
3. TTL and CMOS outputs are compatible with JEDEC standards JESD36 and JESD52.
4. Based on characterization data, not tested in production.

TABLE 3.4.2: Output Voltage Characteristics, SN8205/SN8205UFL

Symbol	Parameter	Conditions	Min	Max	Unit
V_{OL} (2)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	CMOS port(3) I_{IO}=+ 8mA 2.7 V < V_{DD} < 3.6 V	-	0.4	V
V_{OH} (3)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		V_{DD}—0.4		
V_{OL} (2)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	TTL port(3) I_{IO} = +8 mA 2.7 V < V_{DD} < 3.6 V	-	0.4	V
V_{OH} (3)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		2.4		
V_{OL} (2)(4)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	I_{IO} = +20 mA 2.7 V < V_{DD} < 3.6 V	-	1.3	V
V_{OL} (3)(4)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		V_{DD}—1.3		
V_{OL} (2)(4)	Output low level voltage for an I/O pin when 8 pins are sunk at same time	I_{IO}= +6 mA 2 V < V_{DD} < 2.7 V		0.4	V
V_{OL} (3)(4)	Output high level voltage for an I/O pin when 8 pins are sourced at same time		V_{DD}—0.4		

1. PC13, PC14, PC15 and PI8 are supplied through the power switch. Since the switch only sinks a limited amount of current (3 mA), the use of GPIOs PC13 to PC15 and PI8 in output mode is limited: the speed should not exceed 2 MHz with a maximum load of 30 pF and these I/Os must not be used as a current source (e.g. to drive an LED).
2. The IIO current sunk by the device must always respect the absolute maximum rating specified in Table 3.4.2 and the sum of IIO (I/O ports and control pins) must not exceed IVSS.
3. The IIO current sourced by the device must always respect the absolute maximum rating specified in Table 3.4.2 and the sum of IIO (I/O ports and control pins) must not exceed IVDD.
4. Based on characterization data, not tested in production.

3.5 I²C Interface Characteristics

Unless otherwise specified, the parameters given below are derived from tests performed under ambient temperature, fPCLK1 frequency and VDD supply voltage conditions. The SN8200/8200UFL and SN8205/8205UFL performance line I²C interface meets the requirements of the standard I²C communication protocol with the following restrictions: the I/O pins to which SDA and SCL are mapped are not "true" open-drain. When configured as open-drain, the PMOS connected between the I/O pin and VDD is disabled, but is still present. The I²C characteristics are described in Table 3.5.1 and Table 3.5.2.

TABLE 3.5.1: I²C Characteristics SN8200/8200UFL

Symbol	Parameter	Standard mode		Fast mode I2C(1)		Unit
		M	Max	Min	Max	
$t_{w(SCLL)}$	SCL clock low time	4.7	-	1.3	-	µs
$t_{w(SCLH)}$	SCL clock high time	4.0	-	0.6	-	
$t_{su(SDA)}$	SDA setup time	250	-	100	-	ns
$t_{h(SDA)}$	SDA data hold time	0(3)	-	0(4)	900(3)	
$t_{r(SDA)}$ $t_{r(SCL)}$	SDA and SCL rise time	-	1000	20 + 0.1C_b	300	
$t_{f(SDA)}$ $t_{f(SCL)}$	SDA and SCL fall time	-	300	-	300	
$t_{h(STA)}$	Start condition hold time	4.0	-	0.6	-	µs
$t_{su(STA)}$	Repeated Start condition setup time	4.7	-	0.6	-	
$t_{su(STO)}$	Stop condition setup time	4.0	-	0.6	-	µs
$t_{w(STO:STA)}$	Stop to Start condition time (bus free)	4.7	-	1.3	-	µs
C_b	Capacitive load for each bus line	-	400	-	400	pF

1. Guaranteed by design, not tested in production.
2. fPCLK1 must be at least 2 MHz to achieve standard mode I²C frequencies. It must be at least 4 MHz to achieve the fast mode I²C frequencies and it must be a multiple of 10 MHz in order to reach the I²C fast mode maximum clock speed of 400 kHz.
3. The maximum hold time of the Start condition has only to be met if the interface does not stretch the low period of SCL signal.
4. The device must internally provide a hold time of at least 300ns for the SDA signal in order to bridge the undefined region of the falling edge of SCL.

TABLE 3.5.2: I²C Characteristics SN8205/8205UFL

Symbol	Parameter	Standard mode		Fast mode I2C(1		Unit
		M	Max	Min	Max	
$t_{w(SCLL)}$	SCL clock low time	4.7	-	1.3	-	µs
$t_{w(SCLH)}$	SCL clock high time	4.0	-	0.6	-	
$t_{su(SDA)}$	SDA setup time	250	-	100	-	ns
$t_{h(SDA)}$	SDA data hold time	0	-	0	900(3)	
$t_{r(SDA)}$ $t_{r(SCL)}$	SDA and SCL rise time	-	1000	20 + 0.1C_b	300	
$t_{f(SDA)}$ $t_{f(SCL)}$	SDA and SCL fall time	-	300	-	300	
$t_{h(STA)}$	Start condition hold time	4.0	-	0.6	-	µs
$t_{su(STA)}$	Repeated Start condition setup time	4.7	-	0.6	-	
$t_{su(STO)}$	Stop condition setup time	4.0	-	0.6	-	µs
$t_{w(STO:STA)}$	Stop to Start condition time (bus free)	4.7	-	1.3	-	µs
C_b	Capacitive load for each bus line	-	400	-	400	pF

1. Guaranteed by design, not tested in production.
2. f_{PCLK1} must be at least 2 MHz to achieve standard mode I2C frequencies. It must be at least 4 MHz to achieve fast mode I2C frequencies, and a multiple of 10 MHz to reach the 400 kHz maximum I2C fast mode clock.
3. The maximum Data hold time has only to be met if the interface does not stretch the low period of the SCL signal.

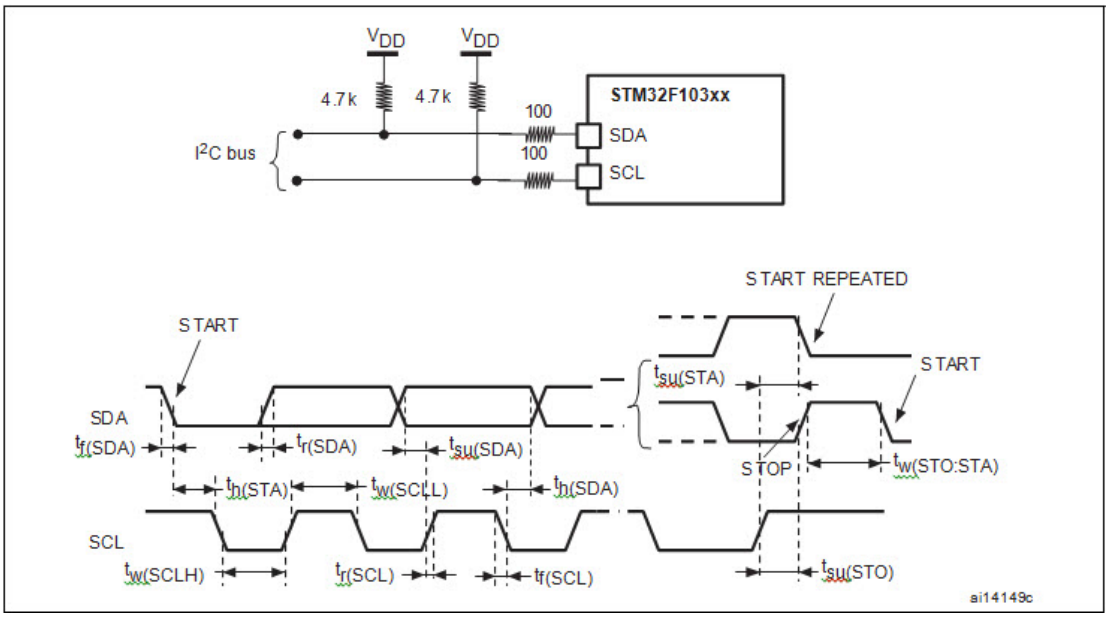

FIGURE 3.1: SN8200/8200UFL I²C bus AC Waveforms and Measurement Circuit

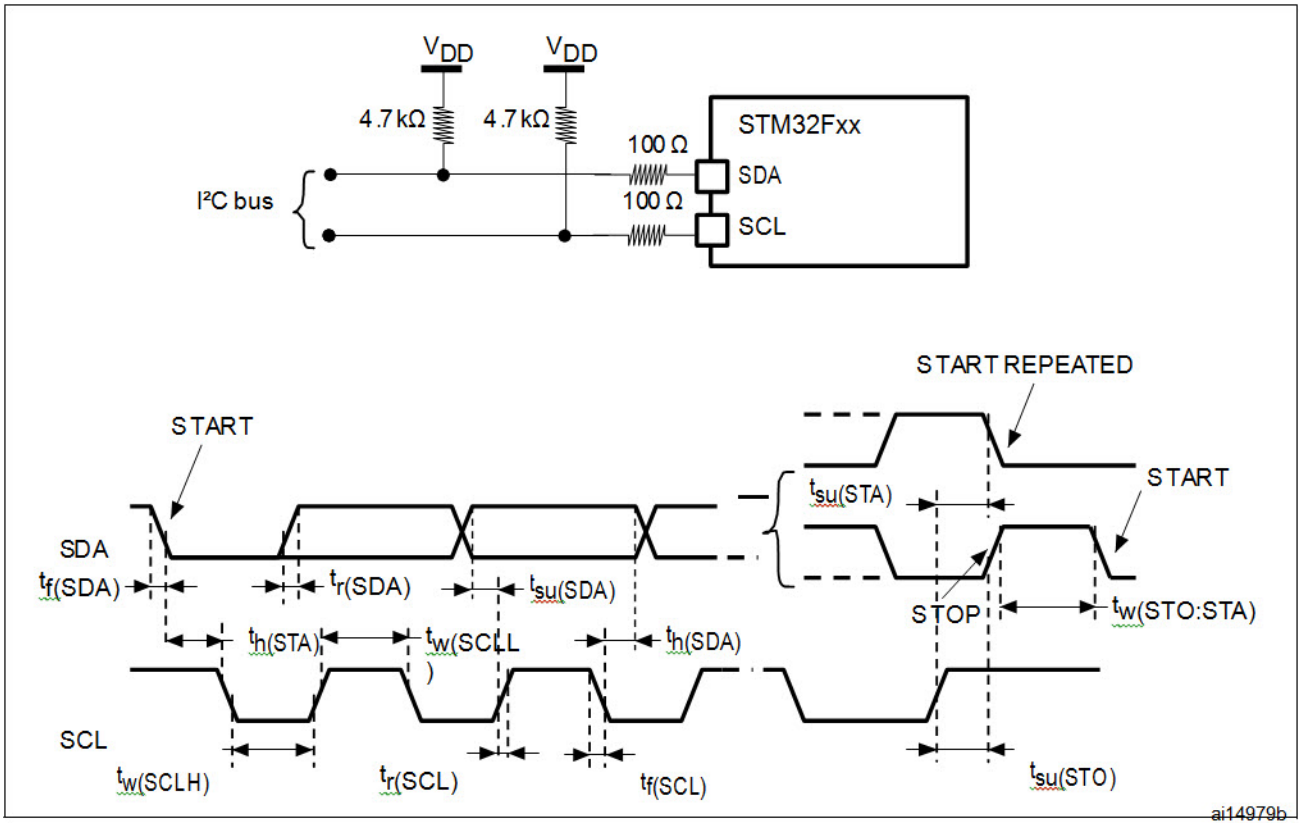

FIGURE 3.2: SN8205/8205UFL I^{2}C bus AC Waveforms and Measurement Circuit

TABLE 3.5.3: SCL Frequency (f_{PCLK1}= 36 MHz., V_{DD} = 3.3 V)(1)(2) SN8200/8200UFL

f_{SCL} (kHz)	I2C_CCR value
	R_P = 4.7 kΩ
400	0x801E
300	0x8028
200	0x803C
100	0x00B4
50	0x0168
20	0x0384

1. R_P = External pull-up resistance, f_{SCL} = I$_2$C speed.
2. For speeds around 200 kHz, the tolerance on the achieved speed is of ±5%. For other speed ranges, the tolerance on the achieved speed is ±2%. These variations depend on the accuracy of the external components used to design the application.

TABLE 3.5.4: SCL Frequency (^{f}PCLK1= 30 MHz., V_{DD} = 3.3 V)(1)(2) SN8205/8205UFL

f_{SCL} (kHz)	I2C_CCR value
	R_P = 4.7 kΩ
400	0x8019
300	0x8021
200	0x8032
100	0x0096
50	0x012C
20	0x02EE

1. R_P = External pull-up resistance, f_{SCL} = I2C speed.
2. For speeds around 200 kHz, the tolerance on the achieved speed is of ±5%. For other speed ranges, the tolerance on the achieved speed is ±2%. These variations depend on the accuracy of the external components used to design the application.

3.6 I^{2}S SPI Characteristics

The I2S interface is multiplexed with SPI and can operate in master or slave mode. Unless otherwise specified, the parameters below for I2S derive from tests performed under ambient temperature, ^{f}PCLKx frequency and V_{DD} supply voltage conditions.

TABLE 3.6.1: SPI Characteristics SN8200/8200UFL

Symbol	Parameter	Conditions	Min	Max	Uni
f_{SCK} $1/t_{c(SCK)}$	SPI clock frequency	Master mode	-	18	MHz
		Slave mode	-	18	
$t_{r(SCK)}$ $t_{f(SCK)}$	SPI clock rise and fall time	Capacitive load: C = 30 pF	-	8	ns
DuCy(SCK)	SPI slave input clock duty cycle	Slave mode	30	70	%
$t_{su(NSS)}$(1)	NSS setup time	Slave mode	$4t_{PCLK}$	-	ns
$t_{h(NSS)}$(1)	NSS hold time	Slave mode	$2t_{PCLK}$	-	
$t_{w(SCLH)}$(1) $t_{w(SCLL)}$(1)	SCK high and low time	Master mode, f_{PCLK} =36MHz, presc = 4	50	60	
$t_{su(MI)}$(1)	Data input setup time	Master mode	5	-	
$t_{su(SI)}$(2)		Slave mode	5	-	
$t_{h(MI)}$(1)	Data input hold time	Master mode	5	-	
$t_{h(SI)}$(1)		Slave mode	4	-	
$t_{a(SO)}$(1)(3)	Data output access	Slave mode, f_{PCLK} = 20 MHz	0	$3t_{PCLK}$	
$t_{dis(SO)}$(1)(2)	Data output disable	Slave mode	2	10	
$t_{v(SO)}$(1)	Data output valid time	Slave mode (after enable edge)	-	25	
$t_{v(MO)}$(1)	Data output valid time	Master mode (after enable edge)	-	5	
$t_{h(SO)}$(1)	Data output hold time	Slave mode (after enable edge)	15	-	
$t_{h(MO)}$(1)		Master mode (after enable edge)	2	-	

1. Based on characterization, not tested in production.
2. Min time is for the minimum time to drive the output and the max time is for the maximum time to validate the data.
3. Min time is for the minimum time to invalidate the output and the max time is for the maximum time to put the data in Hi-Z.

TABLE 3.6.2: SPI Characteristics SN8205/8205UFL

Symbol	Parameter	Conditions	Min	Max	Unit
f_{SCK} $1/t_{c(SCK)}$	SPI clock frequency	SPI1 master/slave mode	-	30	MHz
		SPI2/SPI3 master/slave mode	-	15	
$t_{r(SCL)}$ $t_{f(SCL)}$	SPI clock rise and fall time	Capacitive load: C = 30 pF, f_{PCLK} = 30 MHz	-	8	ns
DuCy(SCK)	SPI slave input clock duty cycle	Slave mode	30	70	%
$t_{su(NSS)}$(1)	NSS setup time	Slave mode	4tPCLK	-	ns
$t_{h(NSS)}$(1)	NSS hold time	Slave mode	2tPCLK	-	
$t_{w(SCLH)}$(1)	SCK high and low time	Master mode, $f_{PCLK=3-MHz}$ presc = 2	t_{PCLK}-3	t_{PCLK}+3	
$t_{su(MI)}$ (1)	Data input setup time	Master mode	5	-	
		Slave mode	5	-	
$t_{h(MI)}$ (1)	Data input hold time	Master mode	5	-	
		Slave mode	4	-	
$t_{a(so)}$(1)(2)	Data output access time	Slave mode, f_{PCLK} = 30 MHz	0	$3t_{PCLK}$	
$t_{dis(SO)}$(1)(3)	Data output disable time	Slave mode	2	10	
$t_{v(SO)}$(1)	Data output valid time	Slave mode (after enable edge)	-	25	
$t_{v(MO)}$(1)	Data output valid time	Master mode (after enable edge)	-	5	
$t_{h(SO)}$(1)	Data output hold time	Slave mode (after enable edge)	15	-	
$t_{(MO)}$(1)		Master mode (after enable edge)	2	-	

1. Based on characterization, not tested in production.
2. Min time is for the minimum time to drive the output and the max time is for the maximum time to validate the data.
3. Min time is for the minimum time to invalidate the output and the max time is for the maximum time to put the data in Hi-Z

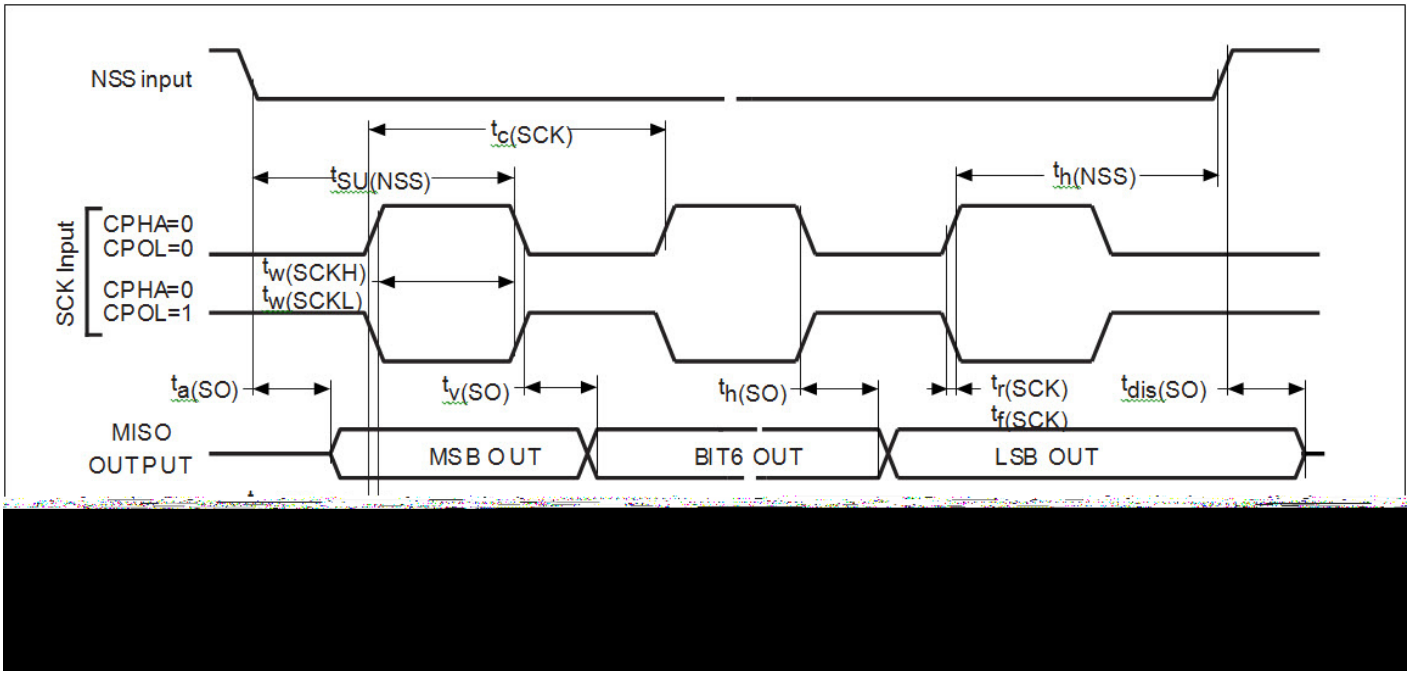

FIGURE 3.3: SPI Timing Diagram - Slave Mode and CPHA = 0, SN8200/8200UFL and SN8205/8205UFL

FIGURE 3.4: SPI Timing Diagram - Slave Mode and CPHA = 1[(1)]SPI Timing Diagram - Slave Mode and CPHA = 0, SN8200/8200UFL and SN8205/8205UFL

1. Measurement points are done at CMOS levels: $0.3V_{DD}$ and $0.7\ V_{DD}$.

TABLE 3.7.5: ADC Characteristics, SN8205/8205UFL

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DDA}	Power supply		1.8(1)	-	3.6	V
V_{REF+}	Positive reference voltage		1.8(1)	-	VDDA	V
f_{ADC}	ADC clock frequency	VDDA = 1.8(1) to 2.4 V	0.6	-	15	MHz
		VDDA = 2.4 to 3.6 V	0.6	-	30	MHz
f_{TRIG}(3)	External trigger frequency	fADC = 30 MHz with 12-bit resolution	-	-	1764	kHz
			-	-	17	$1f_{ADC}$
V_{AIN}	Conversion voltage range(4)		0 (V_{SSA} or V_{REF-} tied to ground)	-	VREF+	V
R_{AIN}(3)	External input impedance	See Equation 1 for details	-	-	50	kΩ
R_{ADC}(3,5)	Sampling switch resistance		1.5	-	6	kΩ
C_{ADC}(3)	Internal sample and hold capacitor		-	4	-	pF
t_{lat} (3)	Injection trigger conversion latency	f_{ADC} = 30 MHz	-	-	0.100	µs
			-	-	3(6)	$1/f_{ADC}$
t_{latr} (3)	Regular trigger conversion latency	f_{ADC} = 30 MHz	-	-	0.067	µs
			-	-	2(6)	$1/f_{ADC}$
t_s(3)	Sampling time	f_{ADC} = 30 MHz	0.100	-	16	µs
			3	-	480	$1/f_{ADC}$
t_{STAB}(3)	Power-up time		-	2	3	µs
t_{CONV}(3)	Total conversion time (including sampling time)	f_{ADC} = 30 MHz 12-bit resolution	0.5	-	16.40	µs
		f_{ADC} = 30 MHz 10-bit resolution	0.43	-	16.34	µs
		f_{ADC} = 30 MHz 8-bit resolution	0.37	-	16.27	µs
		f_{ADC} = 30 MHz 6-bit resolution	0.3	-	16.20	µs
		9 to 492 (tS for sampling +n-bit resolution for successive approximation)				$1/f_{ADC}$
f_s(3)	Sampling rate (f_{ADC} = 30 MHz)	12-bit resolution Single ADC	-	-	2	Msps
		12-bit resolution Interleave Dual ADC mode	-	-	3.75	Msps
		12-bit resolution Interleave Triple ADC mode	-	-	6	Msps

TABLE 3.7.5: ADC Characteristics, SN8205/8205UFL (Continued)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_{VREF+}(3)	ADC V_{REF} DC current consumption in conversion mode	f_{ADC} = 30 MHz 3 sampling time 12-bit resolution	-	300	500	µA
		f_{ADC} = 30 MHz 480 sampling time 12-bit resolution	-	-	16	µA
I_{VDDA}(3)	ADC VDDA DC current consumption in conversion mode	f_{ADC} = 30 MHz 3 sampling time 12-bit resolution	-	1.6	1.8	mA
		f_{ADC} = 30 MHz 480 sampling time 12-bit resolution	-	-	60	µA

1. If IRROFF is set to V_{DD}, this value can be lowered to 1.7 V when the device operates in the 0 to 70 °C temperature range.
2. It is recommended to maintain the voltage difference between V_{REF+} and V_{DDA} below 1.8 V.
3. Based on characterization, not tested in production.
4. V_{REF+} is internally connected to V_{DDA} and V_{REF-} is internally connected to V_{SSA}.
5. R_{ADC} maximum value is given for V_{DD}=1.8 V, and minimum value for V_{DD}=3.3 V.
6. For external triggers, a delay of 1/f_{PCLK2} must be added to the latency specified above.

Equation 1: SN8205/8205UFL R_{AIN} Max Formula

$$R_{AIN} = \frac{(k - 0.5)}{f_{ADC} \times C_{ADC} \times \ln(2^{N+2})} - R_{ADC}$$

The formula above (Equation 1) is used to determine the maximum external impedance allowed for an error below 1/4 of LSB. N = 12 (from 12-bit resolution) and k is the number of sampling periods defined in the ADC_SMPR1 register.

TABLE 3.7.6: ADC Accuracy, SN8205/8205UFL

Symbol	Parameter	Test conditions	Typ	Max(2)	Unit
ET	Total unadjusted error	f_{PCLK2} = 60 MHz, f_{ADC} = 30 MHz, R_{AIN} < 10 kΩ, V_{DDA} = 1.8(3) to 3.6 V	±2	±5	LSB
E	Offset error		±1.	±2.5	
E	Gain error		±1.	±3	
ED	Differential linearity error		±1	±2	
EL	Integral linearity error		±1.	±3	

1. Better performance could be achieved in restricted VDD, frequency and temperature ranges.
2. Based on characterization, not tested in production.
3. If IRROFF is set to VDD, this value can be lowered to 1.7 V when the device operates in the 0 to 70 °C temperature range.

NOTE: ADC accuracy vs. negative injection current: injecting a negative current on any analog input pins should be avoided as this significantly reduces the accuracy of the conversion being performed on another analog input. It is recommended to add a Schottky diode (pin to ground) to analog pins which may potentially inject negative currents.

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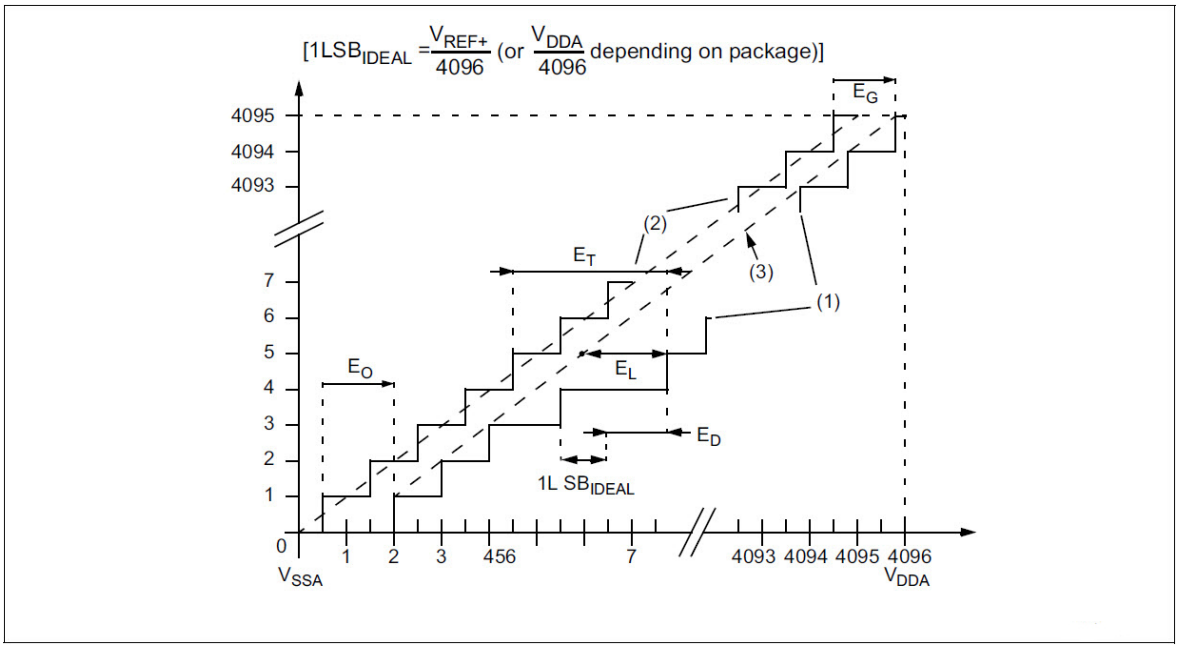

FIGURE 3.7: ADC Accuracy Characteristics, SN8205/8205UFL

1. Example of an actual transfer curve.
2. Ideal transfer curve.
3. End point correlation line.
4. ET = Total Unadjusted Error: maximum deviation between the actual and the ideal transfer curves.
   EO = Offset Error: deviation between the first actual transition and the first ideal one.
   EG = Gain Error: deviation between the last ideal transition and the last actual one.
   ED = Differential Linearity Error: maximum deviation between actual steps and the ideal one.
   EL = Integral Linearity Error: maximum deviation between any actual transition and the end point correlation line.

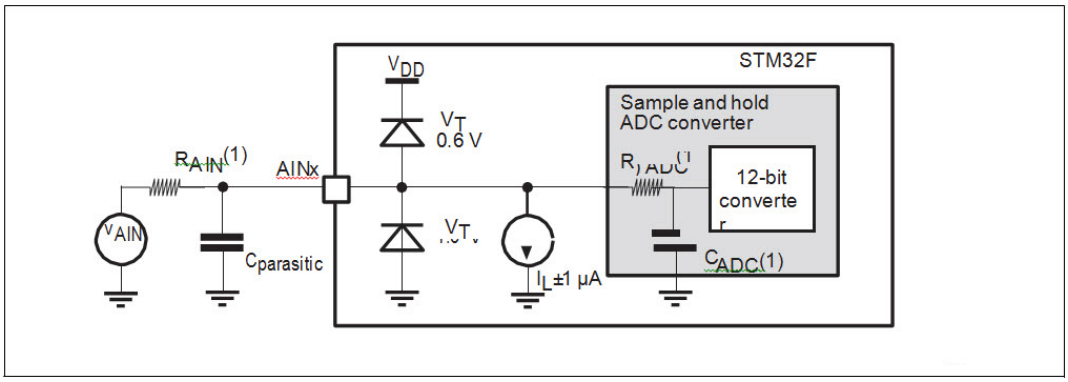

FIGURE 3.8: Typical Connection Diagram Using the ADC, SN8205/8205UFL

Cparasitic represents the capacitance of the PCB (dependent on soldering and PCB layout quality) plus the pad capacitance (roughly 7 pF). A high Cparasitic value downgrades conversion accuracy. To remedy this, fADC should be reduced.

3.8 DAC Electrical Specifications

TABLE 3.8.1: DAC Characteristics, SN8200/8200UFL

Symbol	Parameter	Min	Typ	Max	Unit	Comments
V_{DDA}	Analog supply voltage	2.4	-	3.6	V	
V_{REF+}	Reference supply voltage	2.4	-	3.6	V	V_{REF+} must always be below VDDA
V_{SSA}	Ground	0	-	0	V	
$R_{LOAD(}1)$	Resistive load vs. V_{SSA} with buffer ON	5	-	-	kΩ	
	Resistive load vs. V_{DDA} with buffer ON	15	-	-	kΩ	
R_O(1)	Impedance output with buffer OFF	-	-	15	kΩ	When the buffer is OFF, the Minimum resistive load between DAC_OUT and V_{SS} to have a 1% accuracy is 1.5 MΩ
C_{LOAD}(1)	Capacitive load	-	-	50	pF	Maximum capacitive load at DAC_OUT pin (when the buffer is ON).
DAC_OUT min(1)	Lower DAC_OUT voltage with buffer ON	0.2	-	-	V	It gives the maximum output excursion of the DAC. It corresponds to 12-bit input code (0x0E0) to (0xF1C) at V_{REF+} = 3.6 V and (0x155) and (0xEAB) at V_{REF+} = 2.4 V
DAC_OUT max(1)	Higher DAC_OUT voltage with buffer ON	-	-	V_{DDA} – 0.2	V	
DAC_OUT min(1)	Lower DAC_OUT voltage with buffer OFF	-	0.5		mV	It gives the maximum output excursion of the DAC.
DAC_OUT max(1)	Higher DAC_OUT voltage with buffer OFF	-		V_{REF+} – 10 mV	V	
I_{DDVREF}+	DAC DC current consumption in quiescent mode (Standby mode)	-		380	µA	With no load, worst code (0x0E4) at V_{REF+} = 3.6 V in terms of DC consumption on the inputs
I_{DDA}	DAC DC current consumption in quiescent mode (Standby mode)	-		380	µA	With no load, middle code (0x800) on the inputs
		-		480	µA	With no load, worst code (0xF1C) at V_{REF+} = 3.6 V in terms of DC consumption on the inputs
DNL(2)	Differential non linearity Difference between two consecutive code-1LSB)	-		±0.5	LSB	Given for the DAC in 10-bit configuration
		-		±3	LSB	Given for the DAC in 12-bit configuration
INL(2)	Integral non linearity (difference between measured value at Code i and the value at Code i on a line drawn between Code 0 and last Code 1023)	-	-	±1	LSB	Given for the DAC in 10-bit configuration
		-	-	±4	LSB	Given for the DAC in 12-bit configuration

TABLE 3.8.1: DAC Characteristics, SN8200/8200UFL (Continued)

Symbol	Parameter	Min	Typ	Max	Unit	Comments
Offset (2)	Offset error (difference between measured value at Code (0x800) and the ideal value = $V_{REF+}/2$)	-	-	±10	mV	Given for the DAC in 12-bit configuration
		-	-	±3	LSB	Given for the DAC in 10-bit at V_{REF+} = 3.6 V
		-	-	±12	LSB	Given for the DAC in 12-bit at V_{REF+} = 3.6 V
Gain error (2)	Gain error	-	-	±0.5	%	Given for the DAC in 12bit configuration
$t_{SETTLING}$(2)	Settling time (full scale: for a 10-bit input code transition between the lowest and the highest input codes when DAC_OUT reaches final value±1LSB	-	3	4	µs	$C_{LOAD} \leq 50$ pF, $R_{LOAD} \geq 5$ kΩ
Update rate(2)	Max frequency for a correct DAC_OUT change when small variation in the input code (from code i to i+1LSB)	-	-	1	MS/s	$C_{LOAD} \leq 50$ pF, $R_{LOAD} \geq 5$ kΩ
t_{WAKEUP}(2)	Wakeup time from off state (Setting the ENx bit in the DAC Control register)	-	6.5	10	µs	$C_{LOAD} \leq 50$ pF, $R_{LOAD} \geq 5$ kΩ input code between lowest and highest
PSRR+(1)	Power supply rejection ratio (to VDDA) (static DC measurement	-	–67	–40	dB	No R_{LOAD}, C_{LOAD} = 50 pF

1. Guaranteed by design, not tested in production.
2. Preliminary values.

TABLE 3.8.2: DAC Characteristic, SN8205/8205UFL

Symbol	Parameter	Min	Ty	M	Unit	Comments
V_{DDA}	Analog supply voltage	1.8(1)	-	3.6	V	
V_{REF+}	Reference supply voltage	1.8(1)	-	3.6	V	$V_{REF+} \leq V_{DDA}$
V_{SSA}	Ground	0	-	0	V	
R_{LOAD}(2)	Resistive load with buffer ON	5	-	-	kΩ	
R_O(2)	Impedance output with buffer OFF	-	-	15	kΩ	When the buffer is OFF, the Minimum resistive load between DAC_OUT and VSS to have a 1% accuracy is 1.5 MΩ
C_{LOAD}(2)	Capacitive load	-	-	50	pF	Maximum capacitive load at DAC_OUT pin (when the buffer is ON).
DAC_OUT min(2)	Lower DAC_OUT voltage with buffer ON	0.2	-	-	V	It gives the maximum output excursion of the DAC. It corresponds to 12-bit input code (0x0E0) to (0xF1C) at V_{REF+} = 3.6 V and (0x1C7) to (0xE38) at V_{REF+} = 1.8 V
DAC_OUT max(2)	Higher DAC_OUT voltage with buffer ON	-	-	VDDA – 0.2	V	
DAC_OUT min(2)	Lower DAC_OUT voltage with buffer OFF	-	0.5	-	mV	It gives the maximum output excursion of the DAC.
DAC_OUT max(2)	Higher DAC_OUT voltage with buffer OFF	-	-	VREF+ – 1LSB	V	
I_{VREF+}(4)	DAC DC VREF current consumption in quiescent mode (Standby mode)	-	170	240	µA	With no load, worst code (0x800) at V_{REF+} = 3.6 V in terms of DC consumption on the inputs
		-	50	75		With no load, worst code (0xF1C) at V_{REF+} = 3.6 V in terms of DC consumption on the inputs
I_{DDA}(4)	DAC DC VDDA current consumption in quiescent mode(3)	-	280	380	µA	With no load, middle code (0x800) on the inputs
		-	475	625	µA	With no load, worst code (0xF1C) at V_{REF}+ = 3.6 V in terms of DC consumption on the inputs
DNL(4)	Differential non linearity Difference between two consecutive code-1LSB)	-	-	±0.5	LSB	Given for the DAC in 10-bit configuration.
		-	-	±2	LSB	Given for the DAC in 12-bit configuration.
INL(4)	Integral non linearity (difference between measured value at Code i and the value at Code i on a line drawn between Code 0 and last Code 1023)	-	-	±1	LSB	Given for the DAC in 10-bit configuration.
						Given for the DAC in 12-bit configu-

TABLE 3.8.2: DAC Characteristic, SN8205/8205UFL (Continued)

Symbol	Parameter	Min	Ty	M	Unit	Comments
Offset(4)	Offset error (difference between measured value at Code (0x800) and the ideal value = VREF+/2)	-	-	±10	mV	Given for the DAC in 12-bit configuration
		-	-	±3	LSB	Given for the DAC in 10-bit at VREF+ = 3.6 V
		-	-	±12	LSB	Given for the DAC in 12-bit at VREF+ = 3.6 V
Gain error(4)	Gain error	-	-	±0.5	%	Given for the DAC in 12-bit configuration
$t_{SETTLING}$(4)	Settling time (full scale: for a 10-bit input code transition between the lowest and the highest input codes when DAC_OUT reaches final value ±4LSB	-	3	6	µs	$C_{LOAD} \leq$ 50 pF, $R_{LOAD} \geq$ 5 kΩ
THD(4)	Total Harmonic Distortion Buffer ON	-	-	-	dB	$C_{LOAD} \leq$ 50 pF, $R_{LOAD} \geq$ 5 kΩ
Update rate(2)	Max frequency for a correct DAC_OUT change when small variation in the input code (from code i to i+1LSB)	-	-	1	MS/s	$C_{LOAD} \leq$ 50 pF, $R_{LOAD} \geq$ 5 kΩ
t_{WAKEUP}(4)	Wakeup time from off state (Setting the ENx bit in the DAC Control register)	-	6.5	10	µs	$C_{LOAD} \leq$ 50 pF, $R_{LOAD} \geq$ 5 kΩ input code between lowest and highest possible ones.
PSRR+	Power supply rejection ratio (to VDDA) (static DC measurement)	-	–67	–40	dB	No RLOAD, CLOAD = 50 pF

1. If IRROFF is set to VDD, this value can be lowered to 1.7 V when the device operates in the 0 to 70 °C temperature range.
2. Guaranteed by design, not tested in production.
3. The quiescent mode corresponds to a state where the DAC maintains a stable output level to ensure that no dynamic consumption occurs.
4. Guaranteed by characterization, not tested in production.

4 RF Specifications

4.1 DC/RF Characteristics for IEEE 802.11b

Conditions: 25ºC, VDD_WIFI_IN=3.6 V, VDD= 3.3 V, 11 MBps mode unless otherwise specified. Parameters measured at RF connector.

TABLE 4.1.1: RF Characteristics for IEEE 802.11b

Parameters	Specification			
Standards conformance	IEEE 802.11b			
Modulation	DSSS/CCK			
Physical layer data rate	1,2,5.5,11 Mbps			
RF Characteristics	**Minimum**	**Typical**	**Maximum**	**Unit**
Frequency range	2400	--	2483.5	MHz
Carrier frequency error	-20	--	+20	ppm
Transmit output power [1]	16	18	20	dBm
Spectrum mask				
1st side lobes	--	--	-30	dBr
2nd side lobes	--	--	-50	dBr
Power-on and power-down ramp	--	--	2	µs
RF carrier suppression	15	--	--	dBc
Modulation accuracy (EVM)	--	--	35	%
Out-of-band spurious emissions				
30 MHz to 1 GHz, BW=100 kHz			-96	dBm
1 GHz to 12.75 GHz, BW=1 MHz			-41	dBm
1.8 GHz to 1.9 GHz, BW=1 MHz			-65	dBm
5.15 GHz to5.3 GHz, BW=1 MHz			-85	dBm
Receive sensitivity [1]				
1 Mbps, FER≤ 8%		-96	--	dBm
11 Mbps, FER≤ 8%		-88	--	dBm
Maximum input level, FER≤ 8%	-9.5	--	--	dBm
Adjacent channel rejection, FER≤ 8%	35			dB

Notes:
1. Derate by 1.5 dB for temperatures less than -10ºC or more than +55ºC in both transmit and receive modes.

4.2 DC/RF Characteristics for IEEE 802.11g

Conditions: 25ºC, VDD_WIFI_IN=3.6 V, VDD= 3.3 V, 54 Mbps mode unless otherwise specified. Parameters measured at RF connector.

TABLE 4.2.1: RF Characteristics for IEEE 802.11g

Parameters	Specification			
Standards conformance	IEEE 802.11g			
Modulation	OFDM			
Data rate	6, 9, 12, 18, 24, 36, 48, 54 Mbps			
RF Characteristics	**Minimum**	**Typical**	**Maximum**	**Unit**
Frequency range	2400	--	2483.5	MHz
Carrier frequency error	-20	--	+20	ppm
Transmit output power[1]	12.5	14.5	16.5	dBm
Spectrum mask				
9 MHz to 11 MHz, 0 dB to -20 dB	0		-	dB
11 MHz to 20 MHz, -20 dB to -28 dB	0		-	dB
20 MHz to 30 MHz, -28 dB to -40 dB	0		-	dB
30 MHz to 33 MHz, -40 dB	0		-	dB
Constellation Error (EVM)	--	--	-25	dB
Out-of-band spurious emissions				
30 MHz to 1 GHz, BW=100 kHz			-96	dBm
1 GHz to 12.75 GHz, BW=1 MHz			-41	dBm
1.8 GHz to 1.9 GHz, BW=1 MHz			-65	dBm
5.15 GHz to5.3 GHz, BW=1 MHz			-85	dBm
Received Sensitivity[1]				
6 Mbps, PER ≤ 10%		-89	--	dBm
54 Mbps, PER ≤ 10%		-74	--	dBm
Maximum input level, PER ≤ 10%	-13	--	--	dBm
Adjacent channel rejection, PER ≤ 10%	-1			dB

Notes:

1. Derate by 1.5 dB for temperatures less than -10ºC or more than +55ºC in both transmit and receive modes.

4.3 DC/RF Characteristics for IEEE 802.11n

Conditions: 25º C, VDD_WIFI_IN=3.6 V, VDD= 3.3 V, 65 Mbps mode unless otherwise specified. Parameters measured at RF connector.

TABLE 4.3.1: RF Characteristics for IEEE 802.11n

Parameters	Specification			
Standards conformance	IEEE 802.11n			
Modulation	OFDM			
Data rate	6.5, 13, 19.5, 26, 39, 52, 58.5, 65 Mbps			
RF Characteristics	**Minimum**	**Typical**	**Maximum**	**Unit**
Frequency range	2400	--	2483.5	MHz
Carrier frequency error	-20	--	+20	Ppm
Transmit Output Power[1]	11	13	15	dBm
Spectrum mask				
9 MHz to 11 MHz, 0 dB to -20 dB	0		-	dB
11 MHz to 20 MHz, -20 dB to -28 dB	0		-	dB
20 MHz to 30 MHz, -28 dB to -45 dB	0		-	dB
30 MHz to 33 MHz, -45 dB	0		-	dB
Constellation Error (EVM)	--	--	-28	dB
Out-of-band spurious emissions				
30 MHz to 1 GHz, BW=100 kHz			-96	dBm
1 GHz to 12.75 GHz, BW=1 MHz			-41	dBm
1.8 GHz to 1.9 GHz, BW=1 MHz			-65	dBm
5.15 GHz to 5.3 GHz, BW=1 MHz			-85	dBm
Received Minimum Sensitivity[1]				
65 Mbps, PER ≤ 10%		-71	--	dBm
Maximum input level, PER ≤ 10%	-13			dB
Adjacent channel rejection, PER ≤ 10%	-2			dB

Notes:

1. Derate by 1.5 dB for temperatures less than -10ºC or more than +55ºC in both transmit and receive modes.

5 Environmental Specifications

5.1 Absolute Maximum Rating

TABLE 5.1: Absolute Maximum Rating

Symbol	Description	Minimum	Maximum	Unit
T_{sop}	Specification operating temperature	-30	85	℃
T_{op}*	Operating temperature	-40	85	℃
T_{st}	Storage temperature	-40	85	℃
VDD	Power supply	0	4.0	V
VBAT	Power supply for backup circuitry when VDD is not present.	0	4.0	V
VDD-WiFi	Wi-Fi Power Supply	0	4.0	V
RFin	RF input power		0	dBm
MSL	Moisture Sensitivity Level	3		
RoHS2	Restriction of Hazardous Substances	Compliant		

*Note: RF performance may be degraded at extreme temperatures.

5.2 Recommended Operating Conditions

TABLE 5.2: Recommended Operating Conditions

	Minimum (V)	Typical (V)	Maximum (V)	Supply Current Specification (mA)
VDD	2.4	3.3	3.6	150
VBAT	2.0	3.3	3.6	10
VDD_WiFi	3.0	3.6	4.0	500

6 Regulatory Information

The table below shows the regulatory compliance status of the SN820X Module family.

TABLE 6.1: Regulatory Compliance

Regulatory Body	Standard	Certificate ID
FCC	CFR Part 15	QPU8200
IC	RSS-210	4523A-SN8200
CE		Compliant
ANATEL	Anatel Resolution NO. 506	1322-14-8488

For more information refer to the SN820X Wi-Fi Network Controller Module Family User Manual, reference [3], on page 7.

7 Packing and Marking Information

7.1 Carrier Tape Dimensions

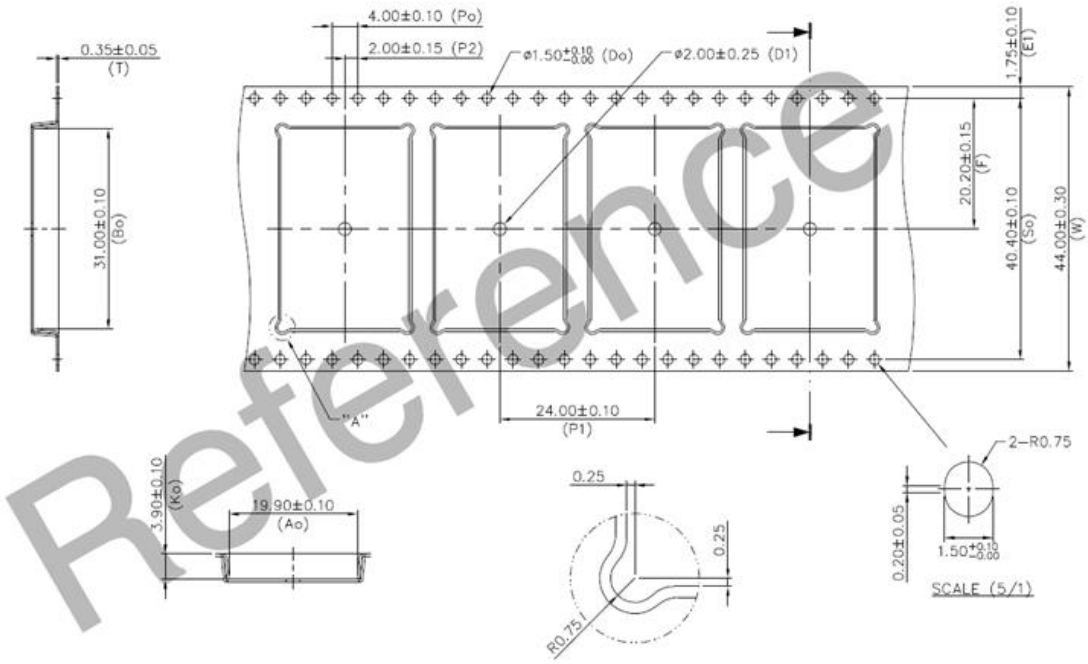

FIGURE 7.1 SN820X/820XUFL Carrier Tape Dimensions

7.2 Module Marking Information

The following marking information may be printed on a permanent label affixed to the module shield or permanently laser written into the module shield itself. The 2D barcode is used for internal purposes. A pin 1 ID is stamped into the shield. The Model will vary according to the module used - SN8200, SN8200UFL, SN8205, SN8205UFL, however the FCC ID and IC certification numbers apply to all modules in the SN820X Family.

FIGURE 7.2 Typical SN820X/820XUFL module marking

Reference

8 RoHS Delcaration

To the best of our present knowledge, given our supplier declarations, this product does not contain substances that are banned by Directive 2002/95/EC or contain a maximum concentration of 0.1% by weight in homogeneous materials for

- Lead and lead compounds
- Mercury and mercury compounds
- Chromium (VI)
- PBB (polybrominated biphenyl)
- PBDE (polybrominated biphenyl ether)

And a maximum concentration of 0.01% by weight in homogeneous materials for

- Cadmium and cadmium compounds

9 Ordering Information

TABLE 9.1: SN8200/8200UFL Ordering Information

Product	RFM Model Number	RFM Part Number	Standard Order Increment
SN8200 Evaluation Kit	SN8200 EVK+	88-00151-95	1 pc
SN8200 Module in Tape & Reel	SN8200	88-00151-00	400 pcs
SN8200UFL Evaluation Kit	SN8200UFL EVK+	88-00151-97	1 pc
SN8200UFL Module in Tape & Reel	SN8200UFL	88-00151-02	400 pcs

TABLE 9.2: SN8205/8205UFL Ordering Information

Product	RFM Model Number	RFM Part Number	Standard Order Increment
SN8205 Evaluation Kit	SN8205 EVK+	88-00158-95	1 pc
SN8205 Module in Tape & Reel	SN8205	88-00158-00	400 pcs
SN8205UFL Evaluation Kit	SN8205UFL EVK+	88-00158-97	1 pc
SN8205UFL Module in Tape & Reel	SN8205UFL	88-00158-02	400 pcs

10 Technical Support Contact

For technical support, please contact tech_sup@murata.com

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